2SA1500

Silicon PNP epitaxial planar type

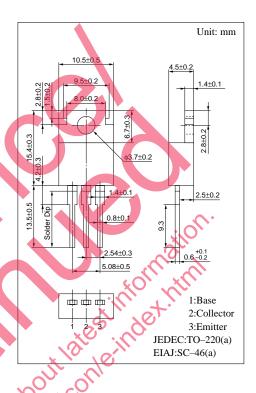
For power switching

Features

- High-speed switching
- ullet High collector to base voltage V_{CBO}
- Wide area of safe operation (ASO)
- Satisfactory linearity of foward current transfer ratio h_{FE}

Absolute Maximum Ratings $(T_C=25^{\circ}C)$

Parameter	Symbol	Ratings	Unit
Collector to base voltage	v _{CBO}	-400	V
Collector to emitter volta	ge V _{CEO}	-400	V
Emitter to base voltage	V _{EBO}	-7	V
Peak collector current	I_{CP}	-8	A
Collector current	I_{C}	-5	Α
Collector power T _C =25°		40	111
dissipation Ta=25°	C P _C	1.4	W
Junction temperature	$T_{\rm j}$	150	°C
Storage temperature	$T_{ m stg}$	-55 to +150	°C



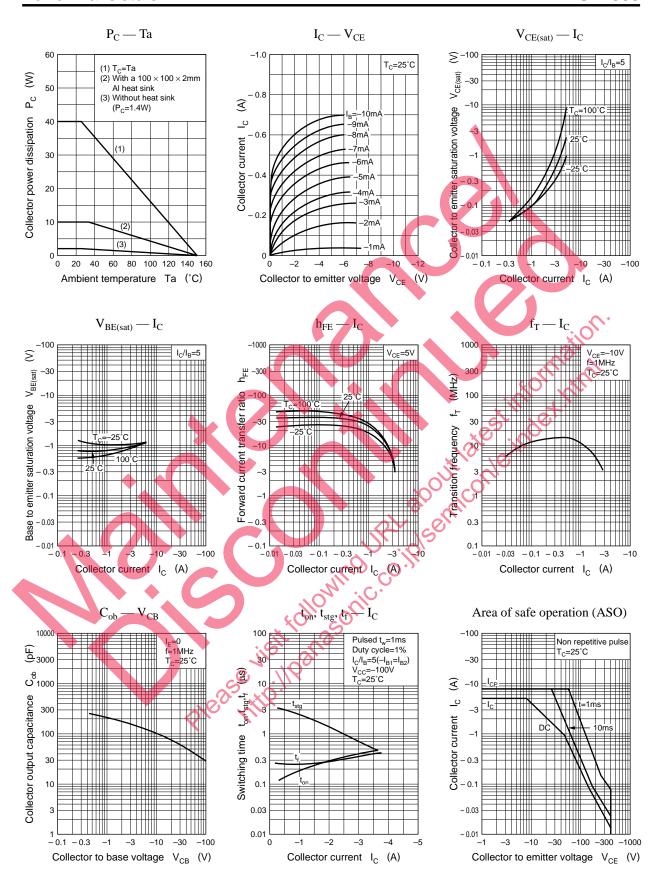
Electrical Characteristics (T_C=25°C)

Parameter	Symbol	Conditions	min	typ	max	Unit
Collector cutoff current	I_{CBO}	$V_{CB} = -400 \text{ V}, I_E = 0$			-100	μА
Emitter cutoff current	I_{EBO}	$V_{EB} = -7V I_C = 0$			-100	μА
Collector to emitter voltage	V _{CEO}	$I_C = 0 \text{ mA}, I_B = 0$	-400			V
Forward current transfer ratio	h _{FE1} *	$V_{CE} = -5VO_{C} = -0.5A$	20		100	
	h _{FE2}	$V_{CE} = -5V, I_{C} = -2A$	8			
Collector to emitter saturation voltage	V _{CE(sat)}	$I_0 = -2A$, $I_B = -0.4A$			-1.0	V
Base to emitter saturation voltage	V _{BE(sat)}	$I_{\rm C} = -2A, I_{\rm B} = -0.4A$			-1.5	V
Transition frequency	f_T	$V_{CE} = -10V, I_{C} = -0.5A, f = 1MHz$		15		MHz
Turn-on time	t _{on}	$I_C = -2A,$			1.0	μs
Storage time	t _{stg}	$I_{B1} = -0.4A, I_{B2} = 0.4A,$			2.5	μs
Fall time	$t_{\rm f}$	$V_{CC} = -100V$			1.0	μs

*h_{FE1} Rank classification

Rank	Q	P		
h _{FE1}	20 to 60	50 to 100		

Power Transistors 2SA1500



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